

OTA

TEST REPORT

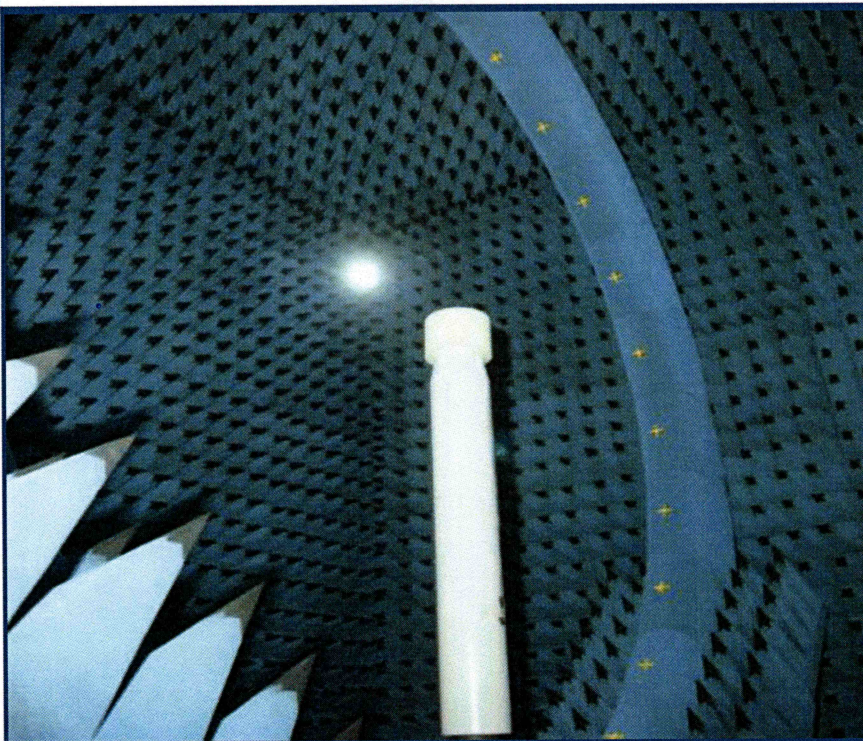
ISSUED BY
Shenzhen BALUN Technology Co., Ltd.

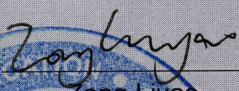


FOR
2.4G dongle

ISSUED TO
SHENZH BOYCHUANG TECHNOLOGY CO., LTD

4th Floor, Building A, Qinyu A District, Sanwei Huafeng First Science and Technology Park, Hangcheng Street, Baoan District, Shenzhen



Tested by: 
Zong Liyao

Date: Jul. 08, 2021

Approved by: 

Liao Jianming
(Technical Director)

Date: Jul. 08, 2021

Report No: BL-SZ2160934-901
EUT Name: 2.4G dongle
Model Name: SE69D
Brand Name: BOYCHUANG
Test Standard: ANSI/IEEE Std 149-1979
Maximum: Gain: -5.92 (dBi)
Efficiency: 9%

Test Date: Jun. 30, 2021
Date of Issue: Jul. 08, 2021

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Revision History

Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>Jul. 08, 2021</u>	<u>Initial Issue</u>

TABLE OF CONTENTS

1	Administrative Data (GENERAL INFORMATION).....	3
1.1	Identification of the Testing Laboratory	3
1.2	Identification of the Responsible Testing Location	3
1.3	Laboratory Condition	3
1.4	Announce	3
2	PRODUCT INFORMATION.....	4
2.1	Applicant Information	4
2.2	Manufacturer Information	4
2.3	Factory Information	4
2.4	General Description for Equipment under Test (EUT)	4
2.5	Ancillary Equipment	4
2.6	Technical Information.....	4
3	SUMMARY OF TEST RESULTS.....	5
3.1	Test Standards.....	5
3.2	Test Verdict.....	5
3.3	Test Uncertainty	5
4	GENERAL TEST CONFIGURATIONS.....	6
4.1	Test Condition	6
4.2	Test Equipment List	6
4.3	Test Setup.....	6
ANNEX A	TEST RESULTS.....	7
A.1	Gain and Efficiency	7
ANNEX B	RADIATION PATTERN	8
ANNEX C	TEST SETUP PHOTO	11
ANNEX D	EUT PHOTO	12

1 Administrative Data (GENERAL INFORMATION)

1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Description	All measurement facilities used to collect the measurement data are located at Block B, FL 1, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China 518055

1.3 Laboratory Condition

Ambient Temperature	19°C to 25°C
Ambient Relative Humidity	45% to 55%
Ambient Pressure	100 kPa to 102 kPa

1.4 Announce

- (1) The test report reference to the report template version v2.2.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (7) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	SHENZH BOYCHUANG TECHNOLOGY CO., LTD
Address	4th Floor, Building A, Qinyu A District, Sanwei Huafeng First Science and Technology Park, Hangcheng Street, Baoan District, Shenzhen
Contact Person	SHENGHAI.LIANG
Telephone Number	18676782100
E-mail Address	liangshenghai2021@126.com

2.2 Manufacturer Information

Manufacturer	SHENZH BOYCHUANG TECHNOLOGY CO., LTD
Address	4th Floor, Building A, Qinyu A District, Sanwei Huafeng First Science and Technology Park, Hangcheng Street, Baoan District, Shenzhen

2.3 Factory Information

Factory	N/A
Address	N/A

2.4 General Description for Equipment under Test (EUT)

EUT Name	2.4G dongle
Model Name Under Test	SE69D
Antenna Type	PCB Antenna
Dimensions	7×5mm

2.5 Ancillary Equipment

N/A

2.6 Technical Information

Frequency Range	2402MHz ~ 2480MHz
Test Frequencies	2402MHz, 2440MHz, 2480MHz

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	ANSI/IEEE Std 149-1979	IEEE Standard Test Procedures for Antennas

3.2 Test Verdict

Report Section	Description	Remark
ANNEX A.1	Gain and Efficiency	--
ANNEX B	Radiation Pattern	--

3.3 Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Item	Uncertainty
VSWR(S11)	± 0.61
Gain	$\pm 1.92\text{dB}$

4 GENERAL TEST CONFIGURATIONS

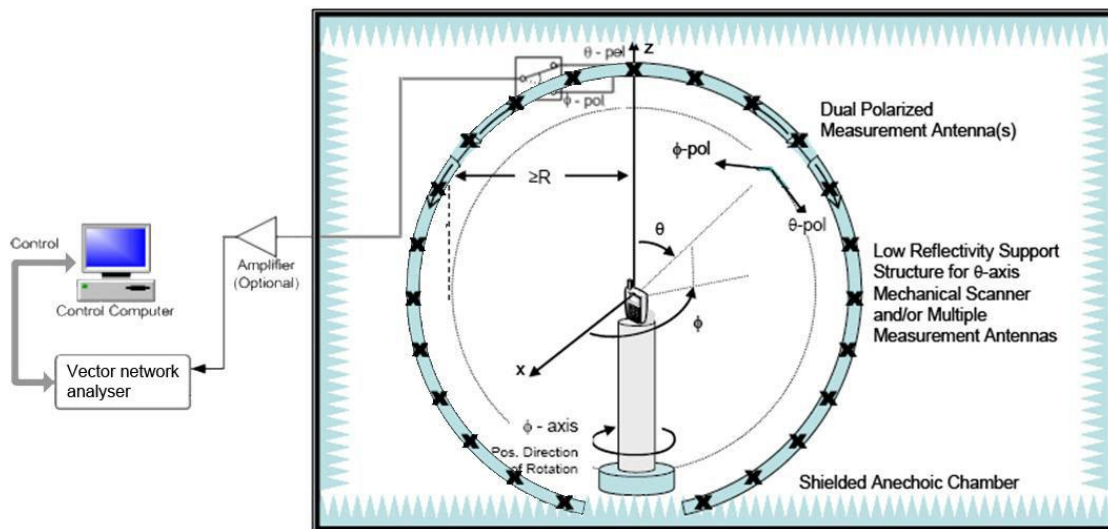
4.1 Test Condition

Environment Parameter	Selected Values During Tests			
	Ambient Pressure(KPa)	Temperature(°C)	Voltage	Relative Humidity (%)
Normal Temperature, Normal Voltage (NTNV)	100 to 102	19 to 25	N/A	45 to 55

4.2 Test Equipment List

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Vector Network Analyzer	Agilent	E5071C	MY46103472	2021.01.26	2022.01.25
SG24 Multi-probe Antenna Measurement System	SATIMO	SG24-L	1101855-0001	2021.05.23	2022.05.24

4.3 Test Setup



ANNEX A TEST RESULTS

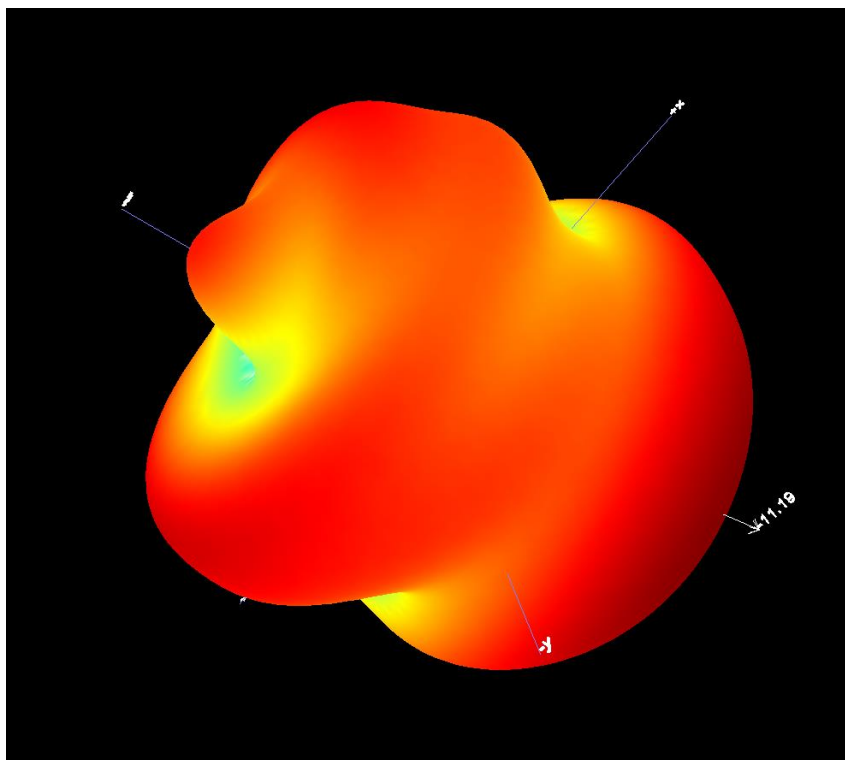
A.1 Gain and Efficiency

Frequency	Gain (dBi)	Efficiency (%)
2402MHz	-11.19	3
2440MHz	-8.39	5
2480MHz	-5.92	9

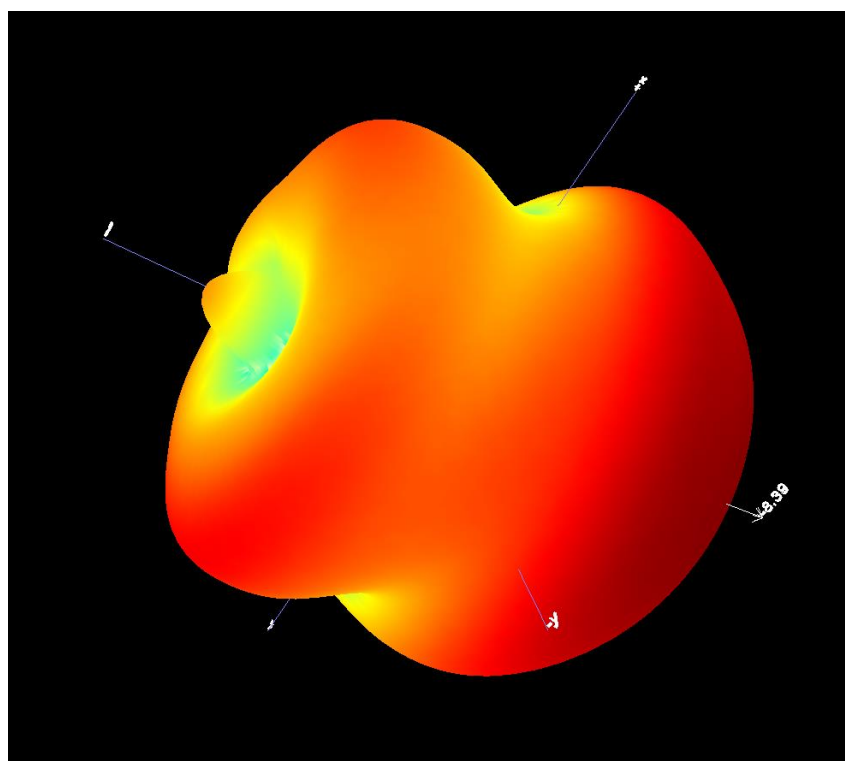
ANNEX B RADIATION PATTERN

B.1 3D Pattern

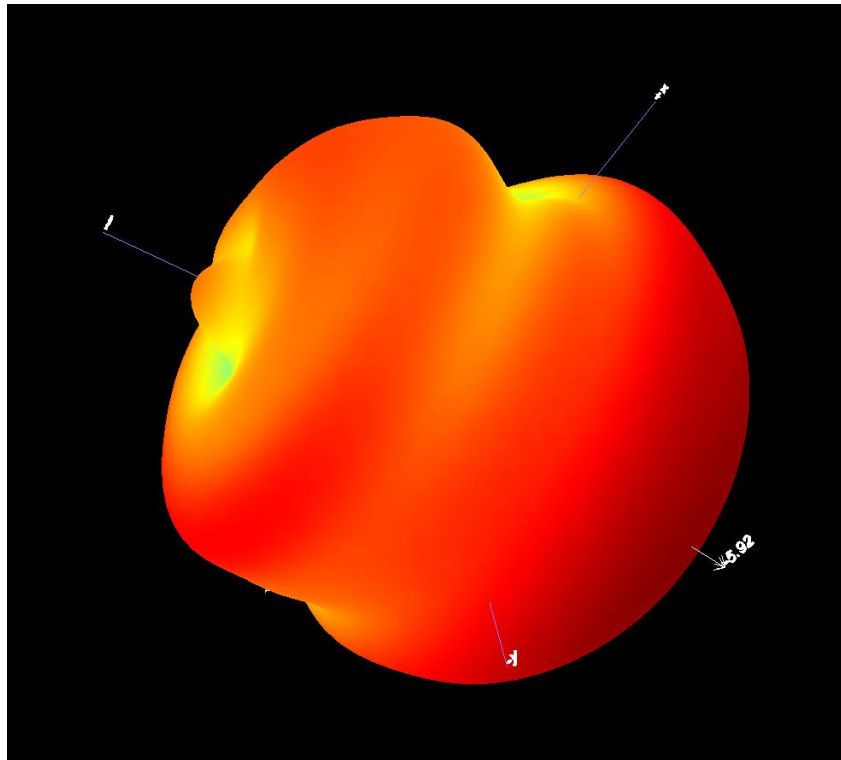
B1.1 3D Pattern for 2402MHz



B1.2 3D Pattern for 2440MHz

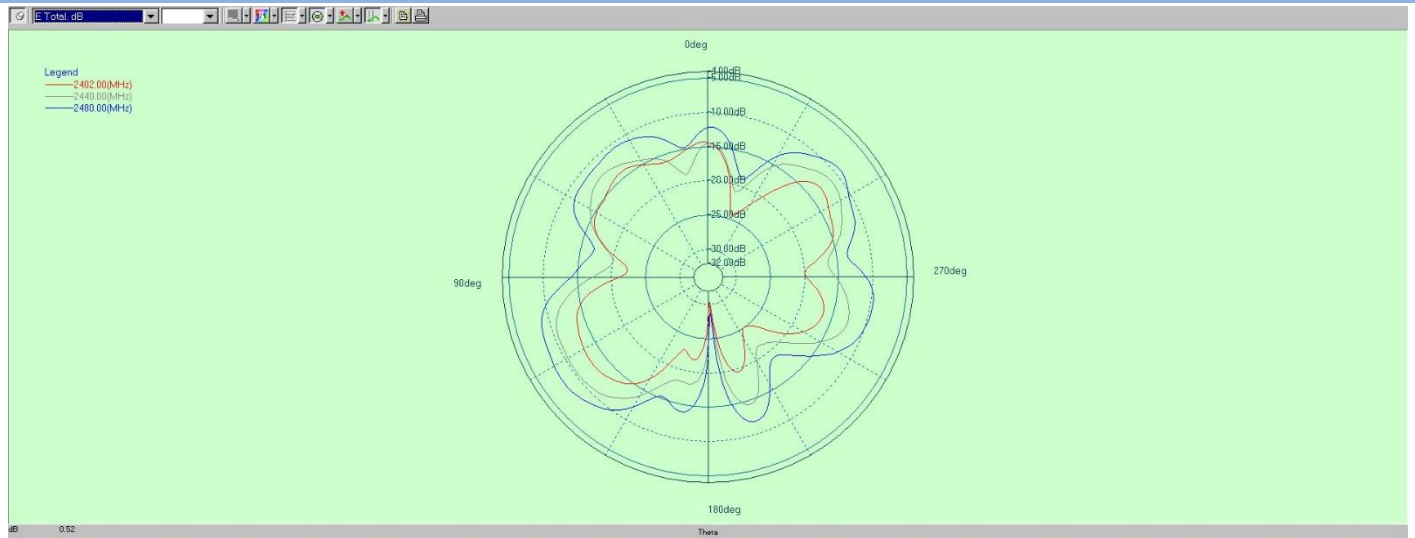


B1.3 3D Pattern for 2480MHz

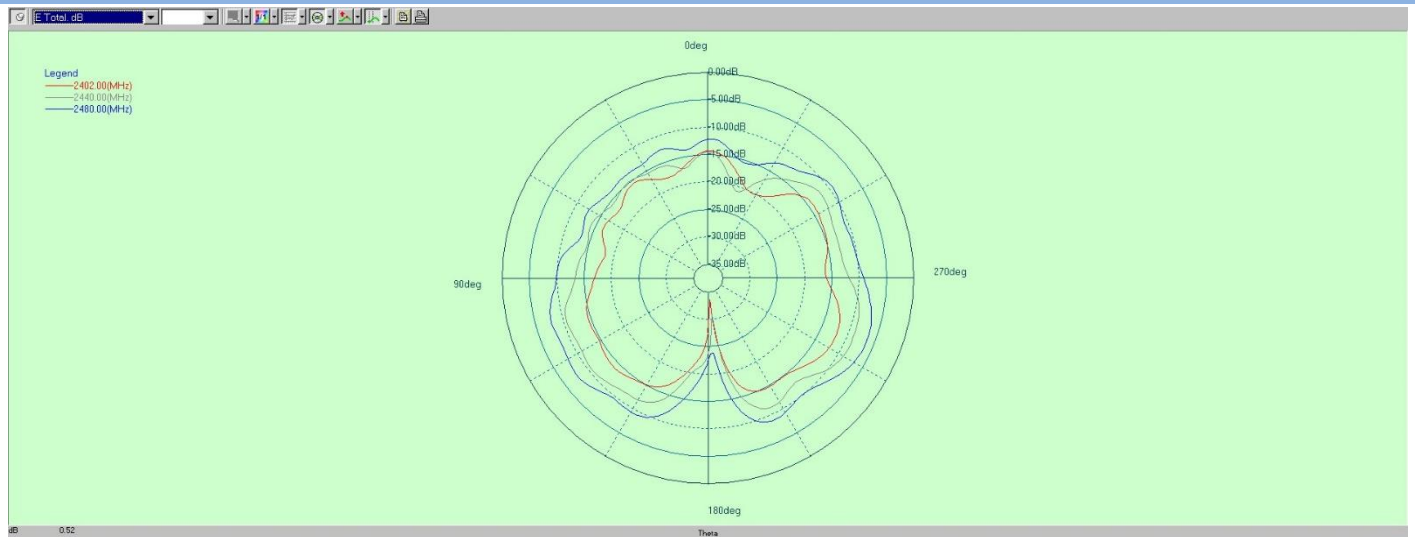


B.2 1D Radiation Pattern

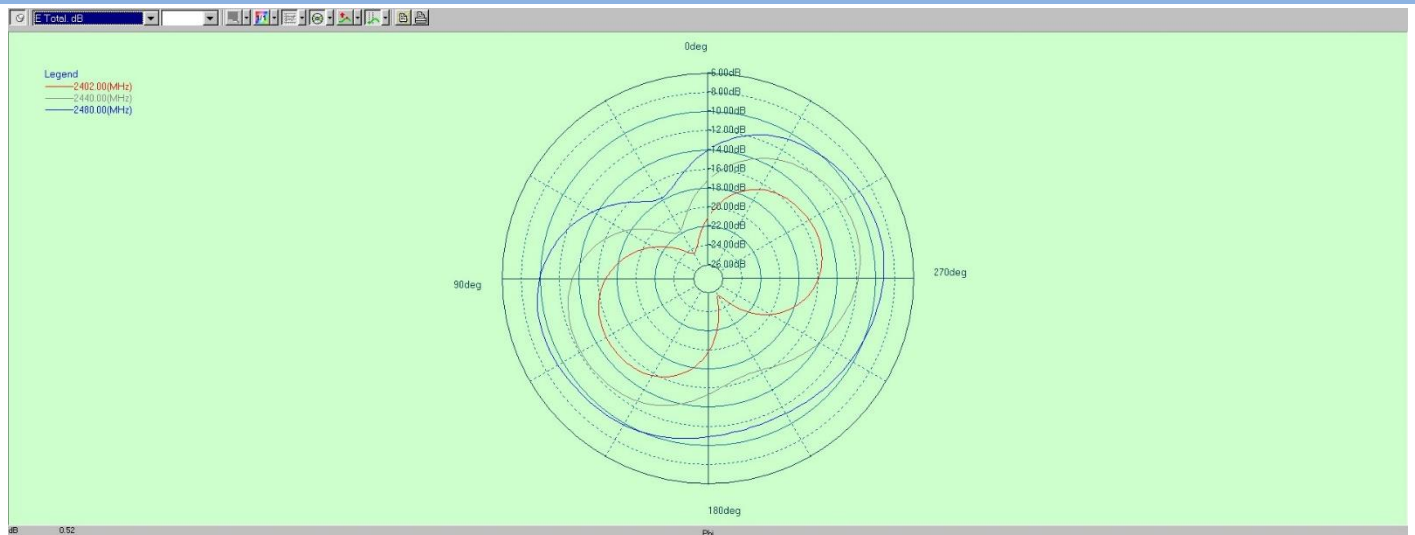
B2.1 PHI=0



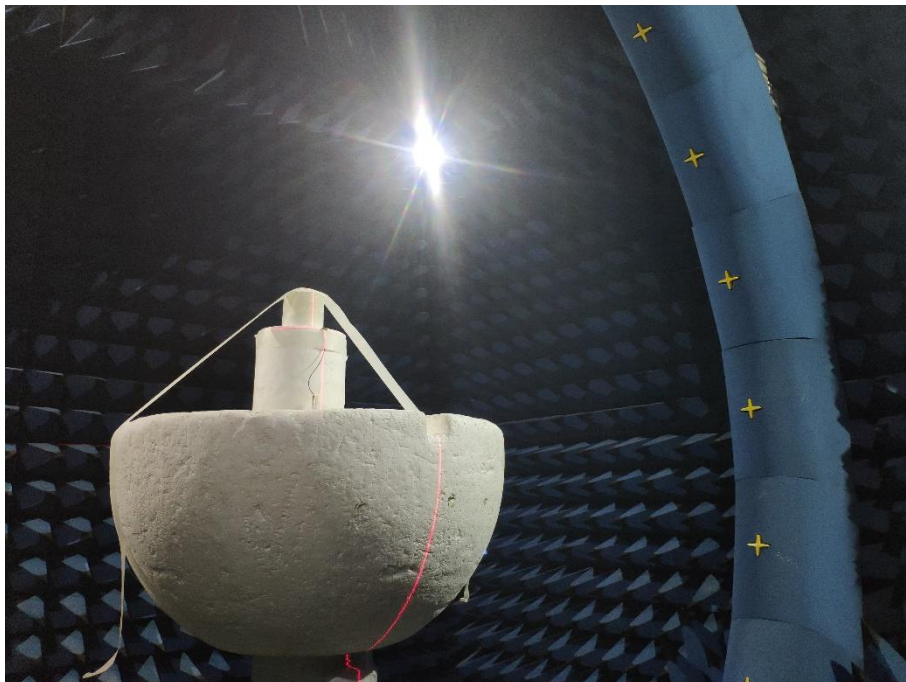
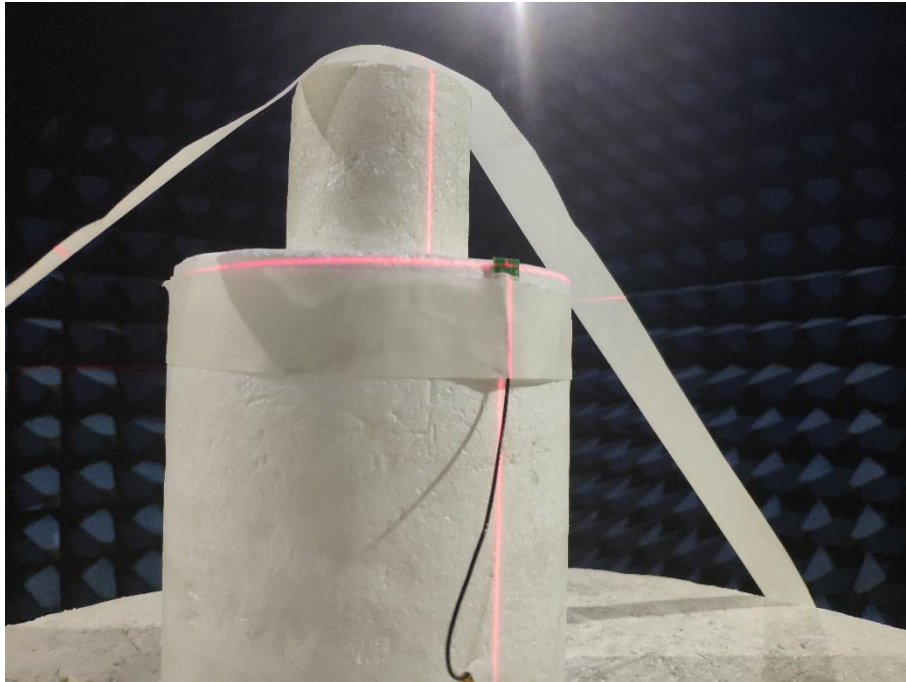
B2.2 PHI=90



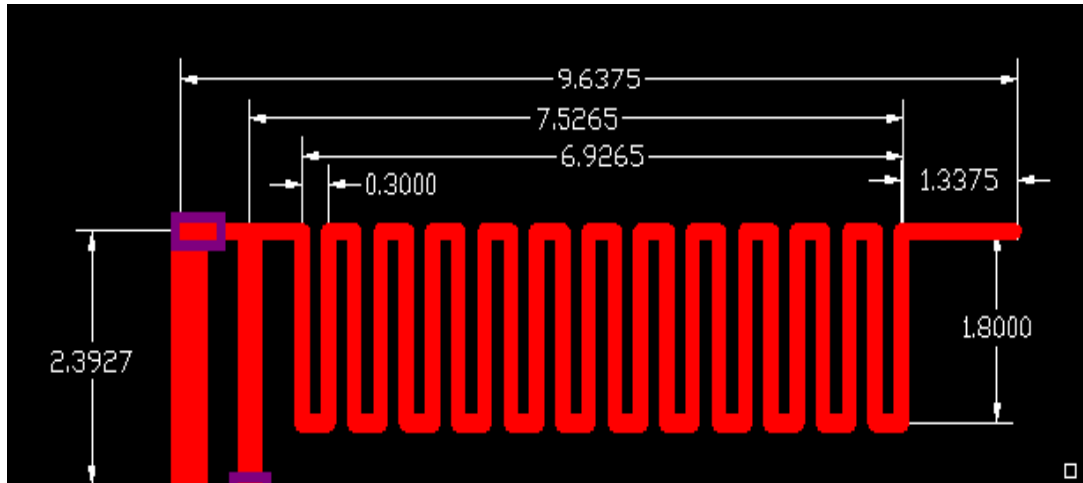
B2.3 THETA=90



ANNEX C TEST SETUP PHOTO



ANNEX D EUT PHOTO



--END OF REPORT--